



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application No.:

10/705,814

Filing Date:

November 10, 2003

Applicant:

Shinichi Nakamura

Group Art Unit:

2861

Examiner:

Lamson D. Nguyen

Title:

Method of Determining An Abnormality Of Nozzles In

Imaging Apparatus; Imaging Apparatus; Electrooptic Device; Method of Manufacturing Electrooptic Device;

and Electronic Equipment

Attorney Docket:

9319H-000586

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

<u>AMENDMENT</u>

Sir:

In response to the Office Action mailed July 12, 2005, please amend the application as follows and consider the remarks set forth below.

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 5 of this paper.